

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10607020	HILL ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Le Nguyen	2174	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	752, 963	11/13/07	lvn
715	752, 963	2/25/2009	lvn
715	752, 963	6/17/2009	lvn

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
confirmed allowance w/Sy Luu	6/21/07	lvn
US-PGPub, USPAT: 715/751-753; 709/204-207	11/13/07	lvn
EPO, JPO	11/13/07	lvn
ACM library, IEEE Xplore	11/13/07	lvn
confirmed allowance w/Raymond Bayerl	6/25/07	lvn
confirmed allowance w/Steve Sax	11/26/07	lvn
updated search	2/25/2009	lvn
updated search	6/17/2009	lvn

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
715	752, 963	11/13/07	lvn
715	752, 963	2/25/2009	lvn
715	752, 963	6/17/2009	lvn

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